

Notice of References Cited

Application/Control No.

10/798,392

Applicant(s)/Patent Under
Reexamination
LEE ET AL.

Examiner

Cheukfan Lee

Art Unit

2625

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,496,285	12-2002	Fujimoto et al.	358/475
	B	US-			
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	D	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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